



PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Organization of:

Covalent Metrology
921 Thompson Place, Sunnyvale, CA 94085

*and hereby declares that the Organization is accredited in accordance with
the recognized International Standard:*

ISO/IEC 17025:2017

Whereby, technical competence has been confirmed for the associated scope supplement, in the fields of:

**Chemical, Dimensional Inspection, Optical, Mechanical, and Non-Destructive
Testing**
(As detailed in the supplement)

Accreditation claims for conformity assessment activities shall only be made from the addresses referenced within this certificate and shall apply solely to those activities identified in the related scope. This Accreditation is granted subject to the Accreditation Body rules governing the Accreditation referred to above, and the Organization hereby commits to observing and complying with those rules in their entirety.

For PJLA:

Tracy Szerszen
President

Perry Johnson Laboratory
Accreditation, Inc. (PJLA)
755 W. Big Beaver, Suite 1325
Troy, Michigan 48084

Initial Accreditation Date: Issue Date: Expiration Date:

November 11, 2025 November 11, 2025 December 31, 2027

Accreditation No.: Certificate No.:
129554 L25-835

*The validity of this certificate is maintained through ongoing assessments based
on a continuous accreditation cycle. The validity of this certificate should be
confirmed through the PJLA website: www.pjilabs.com*



Certificate of Accreditation: Supplement

Covalent Metrology

921 Thompson Place, Sunnyvale, CA 94085

Contact Name: Craig Hunter Email: Craig@covalentmetrology.com

Accreditation is granted to the facility to perform the following conformity assessment activities:

| FIELD OF TEST | ITEMS, MATERIALS, OR PRODUCTS TESTED | COMPONENT, CHARACTERISTIC, PARAMETER TESTED | SPECIFICATION OR STANDARD METHOD | TECHNOLOGY OR TECHNIQUE USED | FLEX CODE | LOCATION OF ACTIVITY |
|------------------------|--------------------------------------|--|---|---|------------|----------------------|
| Non-Destructive | Various Solid Materials | Imaging of solid materials and detection of surface and internal flaws or weaknesses (e.g. voids, delamination, or cracks) | COV-26-SOP AWS C3.7 NASA PEM INST-001 | Scanning Acoustic Microscopy (SAM) | F1, F2, F4 | F |
| Non-Destructive | Crystalline materials | Crystal structure | COV-29-SOP ASTM D5187 | X-Ray Diffraction (XRD) | F1, F2, F4 | F |
| Non-Destructive | Crystalline materials | Phase composition and Preferred Orientation | COV-29-SOP | X-Ray Diffraction (XRD) | F1, F4 | F |
| Non-Destructive | Various Solid Materials | High-resolution 2D and 3D imaging of internal material features | COV-31-SOP | Micro CT (μ CT) | F1, F4 | F |
| Dimensional Inspection | Various Solid Materials | Atomic-resolution imaging to study very small features down to nanoscale. Elemental analysis | COV-11-SOP ISO 29301 | Transmission Electron Microscopy (TEM) | F1, F2, F4 | F |
| Dimensional Inspection | Various Solid Materials | High-resolution imaging and analysis of materials at the nanoscale | COV-12-SOP ASTM E2142 ASTM E766 | Dual Beam Focused Ion Beam (FIB) SEM | F1, F2, F4 | F |
| Dimensional Inspection | Various Solid Materials | High-resolution surface imaging and compositional elemental analysis of a variety of materials | COV-13-SOP ASTM E1508 | Scanning Electron Microscopy/Energy Dispersive Spectroscopy (SEM-EDS) | F1, F2, F4 | F |
| Dimensional Inspection | Various Solid Materials | Surface topography imaging and measurement of mechanical properties of materials | COV-14-SOP ISO 19606 ISO 25178 - 2 | Atomic Force Spectroscopy (AFM) | F1, F2, F4 | F |
| Dimensional Inspection | Various Solid Materials | Surface area, pore size, pore volume, and pore size distribution of materials | COV-23-SOP ISO 9277 ISO 18757 | Physisorption Analyzer (BET) | F1, F2, F4 | F |
| Dimensional Inspection | Various Solid and Liquid Materials | Hydrodynamic size and size distribution of nanoparticles and macromolecules in a liquid | COV-24-SOP ISO 22412 | Dynamic Light Scattering Particle Analysis (DLS) | F1, F2, F4 | F |



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|---------------|--------------------------------------|--|--|--|----------------|----------------------|
| Mechanical | Various Solid Materials | Tensile, compression, bend, peel, and shear forces | COV-19-SOP ASTM E8 ASTM D882 ASTM D638 | Instron Universal Testing Machine (UTM) | F1, F2, F4 | F |
| Mechanical | Various Solid Materials | Hardness, Elastic modulus, and Creep | COV-20-SOP ISO 14577 | Nanoindentation | F1, F2, F4 | F |
| Optical | Various Solid Materials | Surface Imaging and topography (shape and height) of materials over an area, generating 3D maps of the surface | COV-27-SOP IPC-A-600 IPC-A-610 IPC-6012 IPC-TM-650, Method 2.4.53 J-STD-001 ASTM E1382 ASTM E112 ISO 17637 ISO 5817 ASTM E1823 | Optical Microscopy and Profilometry | F1, F2, F4 | F |
| Optical | Various Solid Materials | Thickness, optical constants, and other material properties | COV-22-SOP ASTM F576 (modified) | Spectroscopic Ellipsometry (SE) | F1, F4 | F |
| Chemical | Various Solid and Liquid Materials | Identification of organic compounds and functional groups | COV-15-SOP | Fourier Transform Infrared spectroscopy (FT-IR) | F1, F3, F4 | F |
| Chemical | Various Solid and Liquid Materials | Identification and quantification of volatile, semi-volatile organic and pyrolyzed organic compounds | COV-16-SOP ISO 20595 ASTM D8401-24 | Gas Chromatography Mass Spectrometry (GC-MS) | F1, F2, F3, F4 | F |
| Chemical | Various Solid and Liquid Materials | Quantitative trace elemental analysis | COV-17-SOP ISO 11885 ASTM D1976 | Inductively Coupled Plasma Optical Emission Spectroscopy (ICP-OES) | F1, F2, F3, F4 | F |
| Chemical | Various Solid and Liquid Materials | Quantitative ultra-trace elemental analysis | COV-18-SOP ASTM D5673 ISO 17294-1 UOP1005-14 | Inductively Coupled Plasma Mass Spectrometry (ICP-MS) | F1, F2, F3, F4 | F |



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|---------------|--------------------------------------|---|---------------------------------------|--|----------------|----------------------|
| Chemical | Various Solid and Liquid Materials | Structure, composition, purity, and dynamics | ISO 24583 ASTM E2977 | Nuclear Magnetic Resonance (NMR) | F1, F2, F3, F4 | F |
| Chemical | Various Solid and Liquid Materials | Molecular structure, functional groups, molecular bonds, and crystal structure | COV-25-SOP | Raman Spectroscopy | F1, F2, F3, F4 | F |
| Chemical | Various Solid and Liquid Materials | Identification, quantification, and characterization of substances measuring UV-Vis-NIR transmittance and absorbance. | COV-28-SOP ASTM D1003 ASTM E308 | UV/Vis spectroscopy | F1, F3, F4 | F |
| Chemical | Various Solid Materials | Surface elemental composition, chemical states, and electronic structure of the top 1-10 nanometers of a material | COV-30-SOP ASTM E2735-14 | X-Ray Photoelectron Spectroscopy (XPS) | F1, F2, F3, F4 | F |

1. Location of activity:

Location

F Conformity assessment activity is performed at the CABs fixed facility

Location

2. Flex Code:

- F0- Fixed scope item. No deviations allowed to the line item as identified, except for updating to the most recent version of an accredited standard method after verification.
- F1- Laboratory has the capability to test a new item, material, matrix, or product similar in composition to item, material, matrix, or product identified on the scope
- F2- Laboratory has the capability to introduce the newest revision of an accredited authoritative standard method (with no modifications) identified on the scope
- F3- Laboratory has the capability to introduce a parameter/component/analyte to an accredited test method identified on the scope
- F4- Laboratory has the capability to introduce a new revision of an accredited non-standard method using the same technology or technique identified on the scope
- F5- Laboratory has the capability to introduce a validated method that is equivalent to an accredited method (using same technology or technique) identified on the scope